

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10691212	DORNBUSCH ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	CHRIS CHU	2815

### **SEARCHED**

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
257	E23.052, E23.079, E25.013, E25.018, 678, 684, 686, 693, 698, 728, 777, 778, 786 and 787	5/8/12	C.C.
438	106, 109 and 121	5/8/12	C.C.
333	133 and 193 - 196	5/8/12	C.C.
310	313	5/8/12	C.C.

### **SEARCH NOTES**

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Searched in US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; UPAD; and IBM_TDB;	5/8/12	C.C.

### **INTERFERENCE SEARCH**

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
As same as above	As same as above	5/8/12	C.C.

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